### STL31N65M5



## N-channel 650 V, 0.135 Ω typ., 15 A MDmesh™ V Power MOSFET in a PowerFLAT™ 8x8 HV package

Datasheet - production data

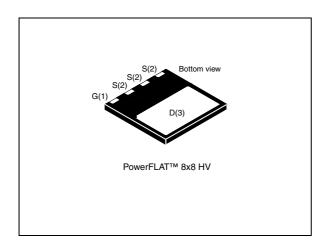
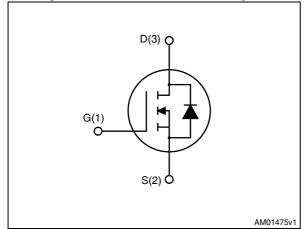


Figure 1. Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STL31N65M5	710 V	$0.162\Omega$	15 A <sup>(1)</sup>

- The value is rated according to R<sub>thj-case</sub> and limited by package.
- Worldwide best R<sub>DS(on)</sub> \* area
- Higher V<sub>DSS</sub> rating and high dv/dt capability
- · Excellent switching performance

#### **Applications**

· Switching applications

#### **Description**

This device is an N-channel MDmesh™ V Power MOSFET based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product has extremely low onresistance, which is unmatched among siliconbased Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

Table 1. Device summary

Order code	Marking	Packages	Packaging
STL31N65M5	31N65M5	PowerFLAT™ 8x8 HV	Tape and reel

Contents STL31N65M5

## **Contents**

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STL31N65M5 Electrical ratings

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	650	٧
V <sub>GS</sub>	Gate-source voltage	± 25	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	15	Α
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100 °C	12	Α
I <sub>DM</sub> (1),(2)	Drain current (pulsed)	60	Α
I <sub>D</sub> <sup>(3)</sup>	Drain current (continuous) at T <sub>amb</sub> = 25 °C	2.8	Α
I <sub>D</sub> (3)	Drain current (continuous) at T <sub>amb</sub> = 100 °C	1.8	Α
P <sub>TOT</sub> (3)	Total dissipation at T <sub>amb</sub> = 25 °C	2.8	W
P <sub>TOT</sub> <sup>(1)</sup>	Total dissipation at T <sub>C</sub> = 25 °C	125	W
I <sub>AR</sub>	Avalanche current, repetitive or not- repetitive (pulse width limited by T <sub>j</sub> max)	5	Α
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 50$ V)	410	mJ
dv/dt (4)	Peak diode recovery voltage slope	15	V/ns
T <sub>stg</sub>	Storage temperature	- 55 to 150	°C
T <sub>j</sub>	Max. operating junction temperature	150	°C

- 1. The value is rated according to  $\ensuremath{R_{thj\text{-}case}}$  and limited by package.
- 2. Pulse width limited by safe operating area.
- 3. When mounted on FR-4 board of inch²,  $2oz\ Cu.$
- 4.  $I_{SD} \leq$  15 A, di/dt  $\leq$  400 A/ $\mu$ s,  $V_{DD} =$  400 V,  $V_{DS(peak)} < V_{(BR)DSS}$ .

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	1	°C/W
R <sub>thj-amb</sub> <sup>(1)</sup>	Thermal resistance junction-ambient max	45	°C/W

1. When mounted on FR-4 board of inch2, 2oz Cu.

Electrical characteristics STL31N65M5

## 2 Electrical characteristics

(T<sub>C</sub> = 25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0	650			V
1	Zero gate voltage	V <sub>DS</sub> = 650 V			1	μΑ
$I_{DSS}   drain current (V_{GS} = 0)$	V <sub>DS</sub> = 650 V, T <sub>C</sub> =125 °C			100	μΑ	
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 25 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3	4	5	٧
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 11 A		0.135	0.162	Ω

**Table 5. Dynamic** 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	1865	-	рF
C <sub>oss</sub>	Output capacitance	$V_{DS} = 100 \text{ V, f} = 1 \text{ MHz,}$	-	45	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	$V_{GS} = 0$	-	4	-	pF
C <sub>o(er)</sub> <sup>(1)</sup>	Equivalent output capacitance energy related	V <sub>GS</sub> = 0,	-	43	-	pF
C <sub>o(tr)</sub> <sup>(2)</sup>	Equivalent output capacitance time related	V <sub>DS</sub> = 0 to 80% V <sub>(BR)DSS</sub>	-	146	-	pF
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz open drain	-	2.8	-	Ω
Qg	Total gate charge	V <sub>DD</sub> = 520 V, I <sub>D</sub> = 11 A,	-	45	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 10 V	-	11.5	-	nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 16)	-	20	-	nC

<sup>1.</sup> Energy related is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 



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<sup>2.</sup> Time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d</sub> (v)	Voltage delay time		-	46	-	ns
t <sub>r</sub> (v)	Voltage rise time	$V_{DD} = 400 \text{ V}, I_D = 14 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$	-	8	-	ns
t <sub>f</sub> (i)	Current fall time	$  \text{G} = 4.7 \Omega, \text{V}_{GS} = 10 \text{ V}$ (see <i>Figure 20</i> )	-	8.5	-	ns
t <sub>c</sub> (off)	Crossing time	,	-	11	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> <sup>(1)</sup>	Source-drain current		-		15	Α
I <sub>SDM</sub> (1),(2)	Source-drain current (pulsed)		-		60	Α
V <sub>SD</sub> (3)	Forward on voltage	voltage $I_{SD} = 15 \text{ A}, V_{GS} = 0$			1.5	V
t <sub>rr</sub>	Reverse recovery time	45 4 41/-14 400 4/	ı	290		ns
Q <sub>rr</sub>	Reverse recovery charge	I <sub>SD</sub> = 15 A, di/dt= 100 A/μs V <sub>DD</sub> = 100 V (see <i>Figure 17</i> )	1	4		μC
I <sub>RRM</sub>	Reverse recovery current	TOD TO T (SEE LIGHT 11)	ı	27		Α
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 15 A, di/dt= 100 A/μs	ı	340		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 100 V, T <sub>j</sub> = 150 °C	-	5		μC
I <sub>RRM</sub>	Reverse recovery current	(see <i>Figure 17</i> )	-	29		Α

<sup>1.</sup> The value is rated according to  ${\rm R}_{\rm thj\text{-}case}$  and limited by package.

<sup>2.</sup> Pulse width limited by safe operating area

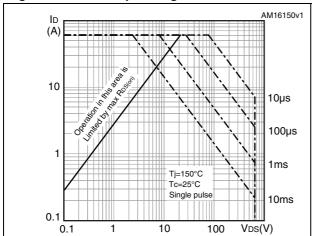
<sup>3.</sup> Pulsed: pulse duration =  $300 \mu s$ , duty cycle 1.5%

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### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance



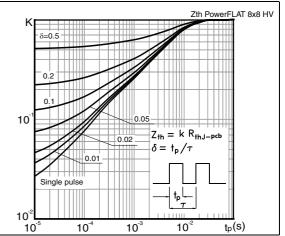
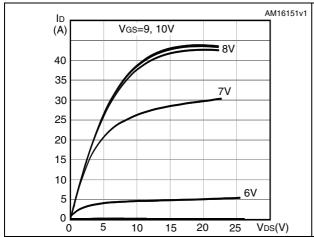


Figure 4. Output characteristics

Figure 5. Transfer characteristics



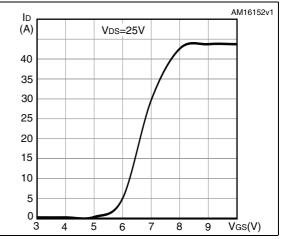
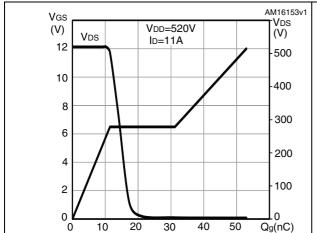
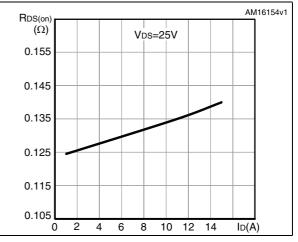


Figure 6. Gate charge vs gate-source voltage Figure 7. Static drain-source on-resistance



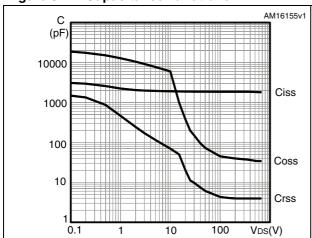


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Figure 8. **Capacitance variations** 

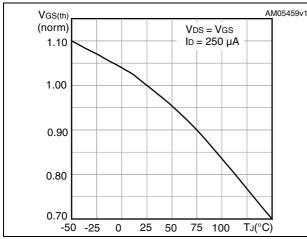
Figure 9. Output capacitance stored energy



AM16159v1 Eoss (µJ) 8 7 6 5 4 3 2 200 400 600 V<sub>DS</sub>(V)

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on-resistance vs. vs. temperature

temperature



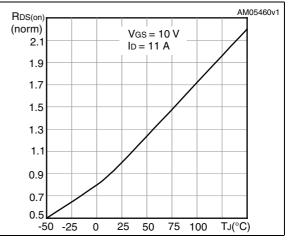
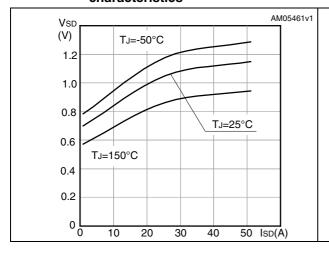
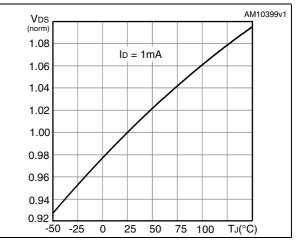


Figure 12. **Drain-source diode forward** characteristics

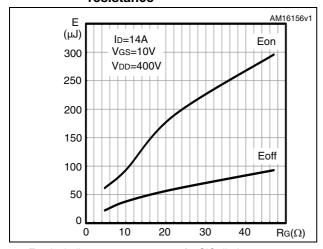
Figure 13. Normalized V<sub>DS</sub> vs. temperature





Electrical characteristics STL31N65M5

Figure 14. Switching losses vs. gate resistance <sup>(1)</sup>



1. Eon including reverse recovery of a SiC diode

STL31N65M5 Test circuits

### 3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

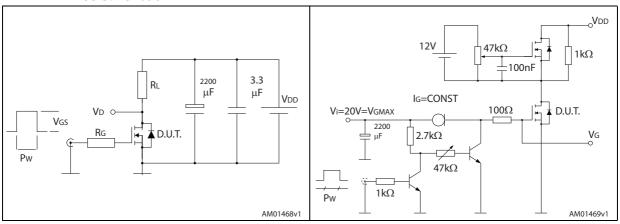


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

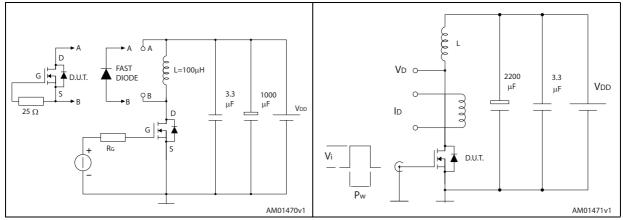
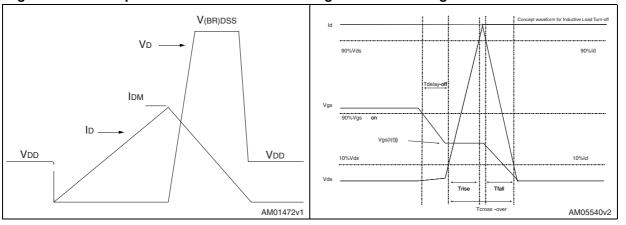


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.



Table 8. PowerFLAT™ 8x8 HV mechanical data

Dim.	mm				
Dilli.	Min.	Тур.	Max.		
А	0.80	0.90	1.00		
A1	0.00	0.02	0.05		
b	0.95	1.00	1.05		
D		8.00			
E		8.00			
D2	7.05	7.20	7.30		
E2	4.15	4.30	4.40		
е		2.00			
L	0.40	0.50	0.60		



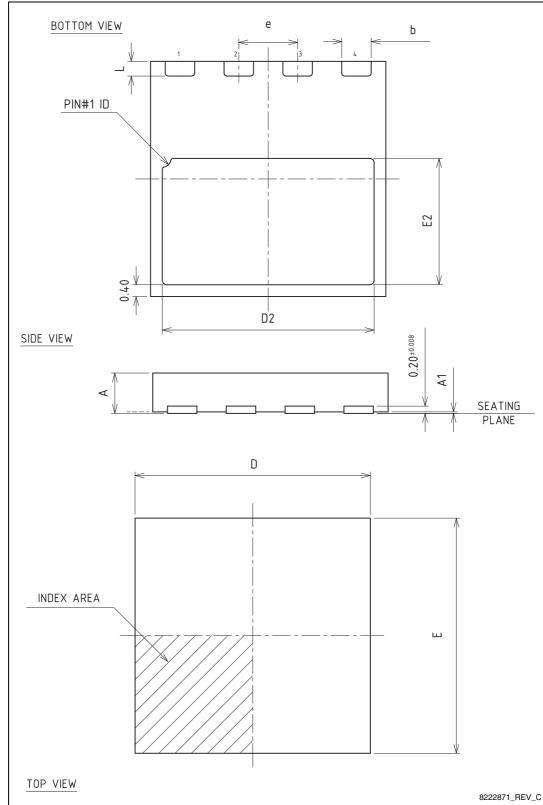


Figure 21. PowerFLAT™ 8x8 HV drawing mechanical data



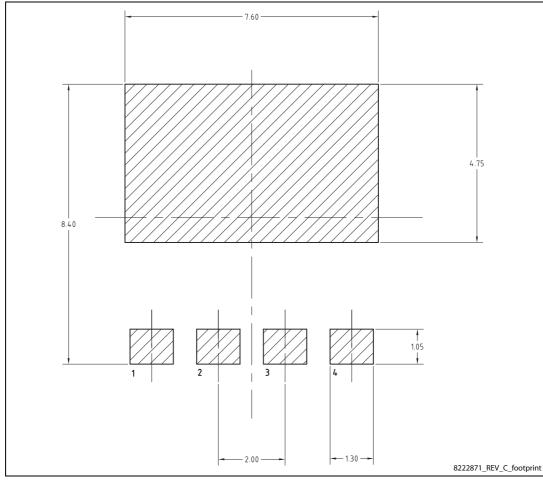


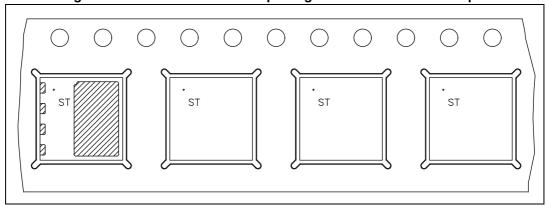
Figure 22. PowerFLAT™ 8x8 HV recommended footprint (dimensions in mm.)

#### Packaging mechanical data 5

P2 (2.0±0.1) D1 (ø1.5 Min) SECTION Y-Y Note: Base and Bulk quantity 3000 pcs 8229819\_Tape\_revA

Figure 23. PowerFLAT™ 8x8 HV tape





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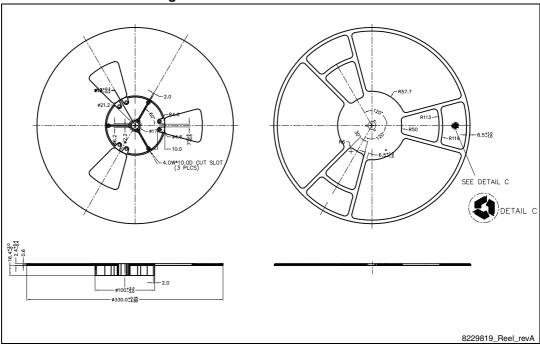


Figure 25. PowerFLAT™ 8x8 HV reel

Revision history STL31N65M5

# 6 Revision history

**Table 9. Document revision history** 

Date	Revision	Changes
31-Oct-2013	1	First release.

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